

FEATURES

- Available in the Texas Instruments NanoStar[™] and NanoFree[™] Packages
- Supports 5-V V_{cc} Operation
- Max t_{nd} of 3.7 ns at 3.3 V

1A [

3Y [

2A [

GND [

- Low Power Consumption, 10-µA Max Icc
- ±24-mA Output Drive at 3.3 V
- Input and Open-Drain Output Accepts Voltages up to 5.5 V

2

3

Typical V_{OLP} (Output Ground Bounce) <0.8 V at $V_{CC} = 3.3 \text{ V}, T_A = 25^{\circ}\text{C}$

DCT PACKAGE

(TOP VIEW)

- Typical V_{OHV} (Output V_{OH} Undershoot) >2 V at $V_{CC} = 3.3 \text{ V}, T_{\Delta} = 25^{\circ}\text{C}$
- Ioff Supports Partial-Power-Down Mode Operation
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- **ESD Protection Exceeds JESD 22**
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)

| | I | | ACKAGE VIEW) | Ξ | YEA, YEP, YZA, OR YZP PACKAGE (BOTTOM VIEW) | | | | |
|----|-------|---|-----------------|-------------------|---|------------------|-----------------|--|--|
| | 1A 🖂 | 1 | 8 | ⊥ v _{cc} | GND 2A | O 4 5O O 3 6O | 2Y 3A | | |
| Ĵ. | 3Y 🗔 | 2 | 7 | <u> 1</u> 11 | 2A 3Y | 0270 | 1Y | | |
| | 2A 🗔 | 3 | 6 | 🔟 3A | 1A | O1 80 | V _{CC} | | |
| | GND 🖽 | 4 | 5 | ∐ 2Y | · | | • | | |

See mechanical drawings for dimensions.

DESCRIPTION/ORDERING INFORMATION

This triple buffer/driver is designed for 1.65-V to 5.5-V V_{CC} operation.

8

7

6

5

____ 3A

2Y ך

1Y

NanoStar[™] and NanoFree[™] package technology is a major breakthrough in IC packaging concepts, using the die as the package.

ORDERING INFORMATION

| T _A | PACKAGE ⁽¹⁾ | | ORDERABLE PART NUMBER | TOP-SIDE MARKING ⁽²⁾ | |
|----------------|--|----------------|-----------------------|---------------------------------|--|
| | NanoStar™ – WCSP (DSBGA) 0.17-mm Small Bump – YEA | | SN74LVC3G07YEAR | | |
| | NanoFree™ – WCSP (DSBGA) 0.17-mm Small Bump – YZA (Pb-free) | - Reel of 3000 | SN74LVC3G07YZAR | | |
| -40°C to 85°C | NanoStar™ – WCSP (DSBGA) 0.23-mm Large Bump – YEP | | SN74LVC3G07YEPR | CV_ | |
| | NanoFree™ – WCSP (DSBGA) 0.23-mm Large Bump – YZP (Pb-free) | | SN74LVC3G07YZPR | | |
| | SSOP – DCT | Reel of 3000 | SN74LVC3G07DCTR | C07 | |
| | VSSOP - DCU | Reel of 3000 | SN74LVC3G07DCUR | 007 | |
| | V350F - DC0 | Reel of 250 | SN74LVC3G07DCUT | C07_ | |

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

(2) DCT: The actual top-side marking has three additional characters that designate the year, month, and assembly/test site. DCU: The actual top-side marking has one additional character that designates the assembly/test site. YEA/YZA, YEP/YZP: The actual top-side marking has three preceding characters to denote year, month, and sequence code, and one following character to designate the assembly/test site. Pin 1 identifier indicates solder-bump composition (1 = SnPb, • = Pb-free).



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DESCRIPTION/ORDERING INFORMATION (CONTINUED)

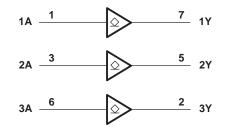
The output of the SN74LVC3G07 is open drain and can be connected to other open-drain outputs to implement active-low wired-OR or active-high wired-AND functions. The maximum sink current is 32 mA.

This device is fully specified for partial-power-down applications using I_{off}. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

FUNCTION TABLE (EACH BUFFER/DRIVER)

| INPUT A | OUTPUT Y |
|------------|-------------|
| Н | Н |
| L | L |

LOGIC DIAGRAM (POSITIVE LOGIC)



Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

| | | | MIN | MAX | UNIT | |
|------------------|---|---|------|------|--------|--|
| V_{CC} | Supply voltage range | | -0.5 | 6.5 | V | |
| VI | Input voltage range ⁽²⁾ | | -0.5 | 6.5 | V | |
| Vo | Voltage range applied to any output in t | he high-impedance or power-off state ⁽²⁾ | -0.5 | 6.5 | V | |
| Vo | Voltage range applied to any output in t | he high or low state ⁽²⁾⁽³⁾ | -0.5 | 6.5 | V | |
| I _{IK} | Input clamp current | V ₁ < 0 | | -50 | mA | |
| I _{OK} | Output clamp current | V ₀ < 0 | | -50 | mA | |
| I _O | Continuous output current | | | ±50 | mA | |
| | Continuous current through V _{CC} or GNE |) | | ±100 | mA | |
| | | DCT package | | 220 | | |
| 0 | Decline we there a line a close $a^{(4)}$ | DCU package | | 227 | 00 AA/ | |
| θ_{JA} | Package thermal impedance ⁽⁴⁾ | YEA/YZA package | | 140 | °C/W | |
| | | YEP/YZP package | | 102 | | |
| T _{stg} | Storage temperature range | · · · · · · · · · · · · · · · · · · · | -65 | 150 | °C | |

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input negative-voltage and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

(3) The value of V_{CC} is provided in the recommended operating conditions table.

(4) The package thermal impedance is calculated in accordance with JESD 51-7.

Recommended Operating Conditions⁽¹⁾

| | | | MIN | MAX | UNIT |
|---|------------------------------------|--|------------------------|----------------------|------|
| V | Supply voltogo | Operating | 1.65 | 5.5 | V |
| V _{CC} | Supply voltage | Data retention only | 1.5 | | V |
| | | V _{CC} = 1.65 V to 1.95 V | 0.65 × V _{CC} | | |
| | I Park Transformation Income | V_{CC} = 2.3 V to 2.7 V | 1.7 | | |
| VIH | High-level input voltage | V_{CC} = 3 V to 3.6 V | 2 | | V |
| | | V _{CC} = 4.5 V to 5.5 V | $0.7 \times V_{CC}$ | | |
| V _{IL} Low-level input voltage | | V _{CC} = 1.65 V to 1.95 V | | $0.35 \times V_{CC}$ | |
| | | V_{CC} = 2.3 V to 2.7 V | | 0.7 | V |
| | Low-level input voltage | $V_{CC} = 3 V \text{ to } 3.6 V$ | | 0.8 | v |
| | | V_{CC} = 4.5 V to 5.5 V | | $0.3 \times V_{CC}$ | |
| VI | Input voltage | | 0 | 5.5 | V |
| Vo | Output voltage | | 0 | 5.5 | V |
| | | V _{CC} = 1.65 V | | 4 | |
| | | V _{CC} = 2.3 V | | 8 | |
| I _{OL} | Low-level output current | V 2V | | 16 | mA |
| | | $V_{CC} = 3 V$ | | 24 | |
| | | $V_{CC} = 4.5 V$ | | 32 | |
| | | $V_{CC} = 1.8 \text{ V} \pm 0.15 \text{ V}, 2.5 \text{ V} \pm 0.2 \text{ V}$ | | 20 | |
| $\Delta t / \Delta v$ | Input transition rise or fall rate | $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$ | | 10 | ns/V |
| | | $V_{CC} = 5 V \pm 0.5 V$ | | 5 | |
| T _A | Operating free-air temperature | | -40 | 85 | °C |

(1) All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | | TEST CONDI | V _{cc} | MIN | TYP ⁽¹⁾ | MAX | UNIT | |
|------------------|----------|--|--------------------------------------|-----------------|--------------------|------|------|----|
| | | I _{OL} = 100 μA | | 1.65 V to 5.5 V | | | 0.1 | |
| | | I _{OL} = 4 mA | | 1.65 V | | | 0.45 | |
| V | | I _{OL} = 8 mA | 2.3 V | | | 0.3 | N | |
| V _{OL} | | I _{OL} = 16 mA | 2.1/ | 0.4 | | | V | |
| | | I _{OL} = 24 mA | 3 V | 0.55 | | | | |
| | | I _{OL} = 32 mA | 4.5 V | | | 0.55 | | |
| I _I | A inputs | V _I = 5.5 V or GND | | 0 to 5.5 V | | | ±5 | μΑ |
| I _{off} | | $V_{\rm I}$ or $V_{\rm O}$ = 5.5 V | | 0 | | | ±10 | μΑ |
| I _{CC} | | $V_{I} = 5.5 \text{ V or GND}, \qquad I_{O}$ | = 0 | 1.65 V to 5.5 V | | | 10 | μΑ |
| ΔI_{CC} | | One input at $V_{CC} - 0.6 V$, Other Othe | her inputs at V _{CC} or GND | 3 V to 5.5 V | | | 500 | μΑ |
| Ci | | $V_{I} = V_{CC}$ or GND | | 3.3 V | | 3.5 | | pF |

(1) All typical values are at V_{CC} = 3.3 V, T_A = 25°C.

SN74LVC3G07 TRIPLE BUFFER/DRIVER WITH OPEN-DRAIN OUTPUTS

SCES365I-AUGUST 2001-REVISED SEPTEMBER 2006

Switching Characteristics

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | V _{CC} = 1.8 V ± 0.15 V | | V_{CC} = 2.5 V ± 0.2 V | | V_{CC} = 3.3 V ± 0.3 V | | V_{CC} = 5 V ± 0.5 V | | UNIT |
|-----------------|-----------------|----------------|-------------------------------------|-----|-----------------------------|-----|-----------------------------|-----|---------------------------|-----|------|
| | (INFUT) | | MIN | MAX | MIN | MAX | MIN | MAX | MIN | MAX | |
| t _{pd} | А | Y | 1.5 | 7.8 | 1 | 4.3 | 1.1 | 3.7 | 1 | 2.9 | ns |

Operating Characteristics

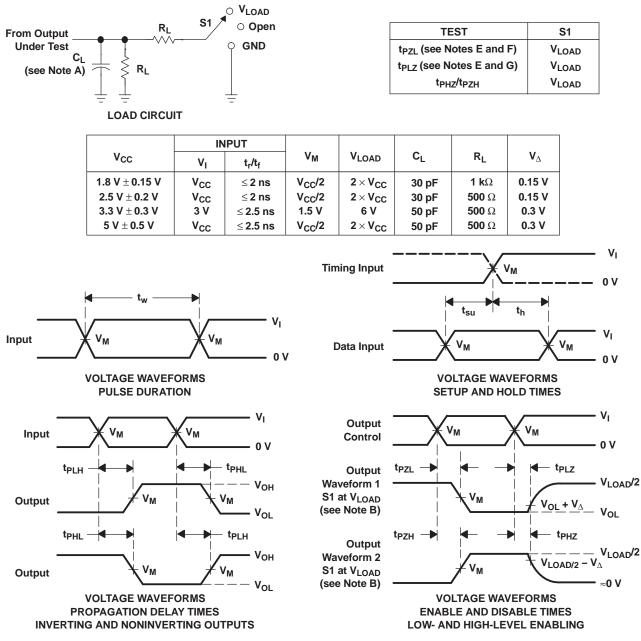
 $T_A = 25^{\circ}C$

| PARAMETER | | TEST CONDITIONS | V _{CC} = 1.8 V V _{CC} = 2.5 | | V _{CC} = 3.3 V | $V_{CC} = 5 V$ | UNIT | |
|-------------------|-------------------------------|-----------------|---|-----|-------------------------|----------------|------|--|
| | FARAMETER | TEST CONDITIONS | TYP | TYP | TYP | TYP | | |
| \mathbf{C}_{pd} | Power dissipation capacitance | f = 10 MHz | 3 | 3 | 4 | 5 | pF | |

SN74LVC3G07 TRIPLE BUFFER/DRIVER WITH OPEN-DRAIN OUTPUTS

SCES365I-AUGUST 2001-REVISED SEPTEMBER 2006

PARAMETER MEASUREMENT INFORMATION (OPEN DRAIN)



NOTES: A. C₁ includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control. C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω .
- D. The outputs are measured one at a time, with one transition per measurement.
- E. Since this device has open-drain outputs, t_{PLZ} and t_{PZL} are the same as t_{pd} .
- F. t_{PZL} is measured at V_M.
- G. t_{PLZ} is measured at $V_{OL} + V_{\Delta}$.
- H. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms

PACKAGING INFORMATION

| Orderable Device | Status ⁽¹⁾ | Package Type | Package Drawing | Pins | Package Qty | e Eco Plan ⁽²⁾ | Lead/Ball Finish | MSL Peak Temp ⁽³⁾ |
|-------------------|-----------------------|-----------------|--------------------|------|----------------|----------------------------|------------------|------------------------------|
| SN74LVC3G07DCTR | ACTIVE | SM8 | DCT | 8 | 3000 | Pb-Free (RoHS) | CU NIPDAU | Level-1-260C-UNLIM |
| SN74LVC3G07DCTRE4 | ACTIVE | SM8 | DCT | 8 | 3000 | Pb-Free (RoHS) | CU NIPDAU | Level-1-260C-UNLIM |
| SN74LVC3G07DCUR | ACTIVE | US8 | DCU | 8 | 3000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN74LVC3G07DCURE4 | ACTIVE | US8 | DCU | 8 | 3000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN74LVC3G07DCUT | ACTIVE | US8 | DCU | 8 | 250 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN74LVC3G07DCUTE4 | ACTIVE | US8 | DCU | 8 | 250 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN74LVC3G07YEAR | NRND | WCSP | YEA | 8 | 3000 | TBD | SNPB | Level-1-260C-UNLIM |
| SN74LVC3G07YEPR | NRND | WCSP | YEP | 8 | 3000 | TBD | SNPB | Level-1-260C-UNLIM |
| SN74LVC3G07YZAR | NRND | WCSP | YZA | 8 | 3000 | Green (RoHS & no Sb/Br) | SNAGCU | Level-1-260C-UNLIM |
| SN74LVC3G07YZPR | ACTIVE | WCSP | YZP | 8 | 3000 | Green (RoHS & no Sb/Br) | SNAGCU | Level-1-260C-UNLIM |

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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MECHANICAL DATA

MPDS049B - MAY 1999 - REVISED OCTOBER 2002

DCT (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion

D. Falls within JEDEC MO-187 variation DA.



DCU (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE (DIE DOWN)



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

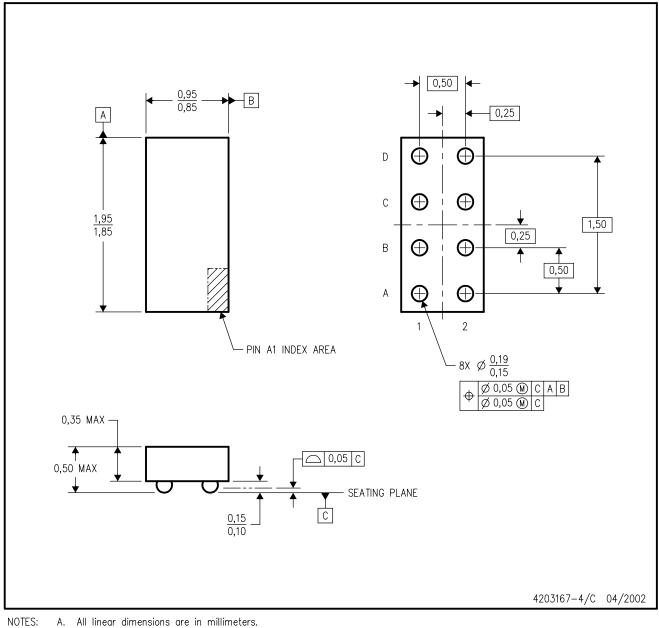
C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.

D. Falls within JEDEC MO-187 variation CA.



YEA (R-XBGA-N8)

DIE-SIZE BALL GRID ARRAY



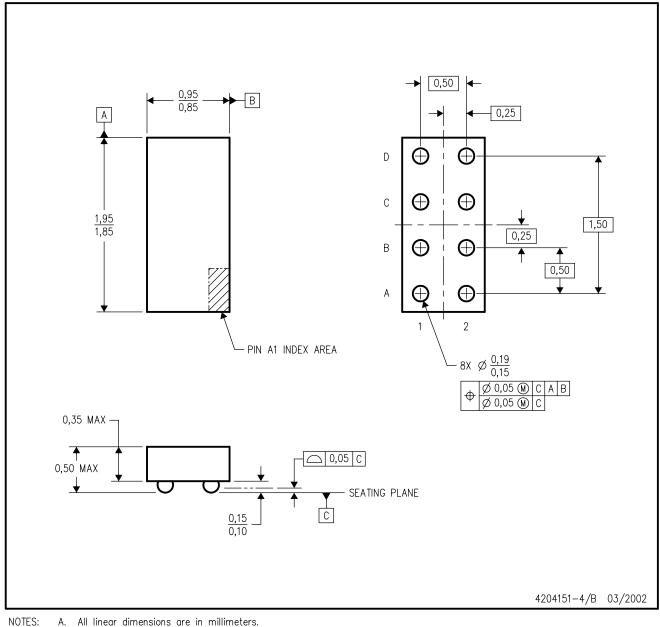
- A. All linear aimensions are in millimeters.B. This drawing is subject to change without notice.
- C. NanoStar™ package configuration.
- D. Package complies to JEDEC MO-211 variation EB.
- E. This package is tin-lead (SnPb). Refer to the 8 YZA package (drawing 4204151) for lead-free.

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YZA (R-XBGA-N8)

DIE-SIZE BALL GRID ARRAY



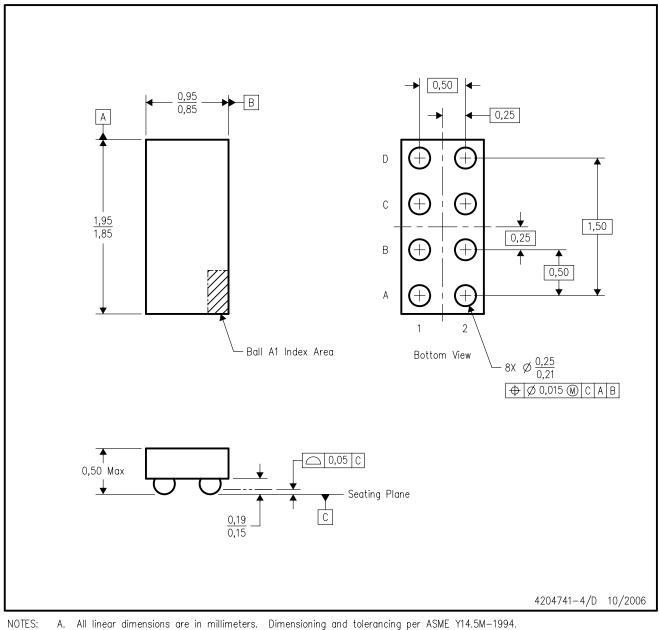
- A. An integral dimensions are in minimeters.B. This drawing is subject to change without notice.
- C. NanoFree™ package configuration.
- D. Package complies to JEDEC MO-211 variation EB.
- E. This package is lead-free. Refer to the 8 YEA package (drawing 4203167) for tin-lead (SnPb).

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YZP (R-XBGA-N8)

DIE-SIZE BALL GRID ARRAY



B. This drawing is subject to change without notice.

C. NanoFree™ package configuration.

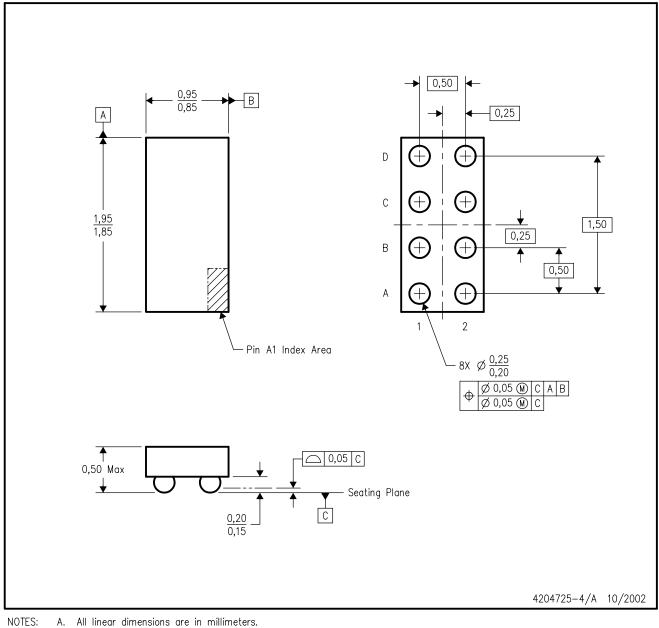
D. This package is lead-free. Refer to the 8 YEP package (drawing 4204725) for tin-lead (SnPb).

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YEP (R-XBGA-N8)

DIE-SIZE BALL GRID ARRAY



- A. All linear almensions are in millimeters.B. This drawing is subject to change without notice.
- C. NanoStar™ package configuration.
- D. This package is tin-lead (SnPb). Refer to the 8 YZP package (drawing 4204741) for lead-free.

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